

Notice of References Cited	Application/Control No. 10/556,455		Applicant(s)/Patent Under Reexamination CHATTING ET AL.	
	Examiner Eric Rush		Art Unit 2624	Page 1 of 1

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*	C	US-2005/0100243	05-2005	Shum et al.	382/276
*	D	US-2003/0206171	11-2003	Kim et al.	345/473
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.